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NOTICE OF ALLOWANCE AND FEE(S) DUE

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7590

06/26/2008

SMITH PATENT OFFICE 1901 PENNSYLVANIA AVENUE N W SUITE 901 WASHINGTON, DC 20006

EXAMINER					
LOGIE, MICHAEL J					
ART UNIT	PAPER NUMBER				
2881					

DATE MAILED: 06/26/2008

APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/521,563	08/01/2005	Detlef Knebel	0075/021001	2956

TITLE OF INVENTION: METHOD FOR LOCALLY HIGHLY RESOLVED, MASS-SPECTROSCOPIC CHARACTERIZATION OF SURFACES USING SCANNING PROBE TECHNOLOGY

APPLN. TYPE SMALL ENTITY ISSUE FEE DUE PUBLICATION FEE DUE PREV. PAID ISSUE FEE TOTAL FEE(S) DUE DATE DUE nonprovisional YES \$720 \$300 \$0 \$1020 09/26/2008

THE APPLICATION IDENTIFIED ABOVE HAS BEEN EXAMINED AND IS ALLOWED FOR ISSUANCE AS A PATENT. PROSECUTION ON THE MERITS IS CLOSED. THIS NOTICE OF ALLOWANCE IS NOT A GRANT OF PATENT RIGHTS. THIS APPLICATION IS SUBJECT TO WITHDRAWAL FROM ISSUE AT THE INITIATIVE OF THE OFFICE OR UPON PETITION BY THE APPLICANT. SEE 37 CFR 1.313 AND MPEP 1308.

THE ISSUE FEE AND PUBLICATION FEE (IF REQUIRED) MUST BE PAID WITHIN THREE MONTHS FROM THE MAILING DATE OF THIS NOTICE OR THIS APPLICATION SHALL BE REGARDED AS ABANDONED. THIS STATUTORY PERIOD CANNOT BE EXTENDED. SEE 35 U.S.C. 151. THE ISSUE FEE DUE INDICATED ABOVE DOES NOT REFLECT A CREDIT FOR ANY PREVIOUSLY PAID ISSUE FEE IN THIS APPLICATION. IF AN ISSUE FEE HAS PREVIOUSLY BEEN PAID IN THIS APPLICATION (AS SHOWN ABOVE), THE RETURN OF PART B OF THIS FORM WILL BE CONSIDERED A REQUEST TO REAPPLY THE PREVIOUSLY PAID ISSUE FEE TOWARD THE ISSUE FEE NOW DUE.

HOW TO REPLY TO THIS NOTICE:

I. Review the SMALL ENTITY status shown above.

If the SMALL ENTITY is shown as YES, verify your current SMALL ENTITY status:

A. If the status is the same, pay the TOTAL FEE(S) DUE shown above

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III. All communications regarding this application must give the application number. Please direct all communications prior to issuance to Mail Stop ISSUE FEE unless advised to the contrary.

IMPORTANT REMINDER: Utility patents issuing on applications filed on or after Dec. 12, 1980 may require payment of maintenance fees. It is patentee's responsibility to ensure timely payment of maintenance fees when due.

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Complete and send this form, together with applicable fee(s), to: Mail Mail Stop ISSUE FEE

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nonprovisional	YES	\$720		\$300	_	\$0		\$1020	09/26/2008	
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LOGIE, M	IICHAEL J	2881		250-306000						
 Change of correspondence address or indication of "Fee Address" (37 CFR 1.363). Change of correspondence address (or Change of Correspondence Address form PTO/SB/122) attached. "Fee Address" indication (or "Fee Address" Indication form PTO/SB/47; Rev 03-02 or more recent) attached. Use of a Customer Number is required. 				(1) the names of up to 3 registered patent attorneys or agents OR, alternatively, (2) the name of a single firm (having as a member a registered attorney or agent) and the names of up to 2 registered patent attorneys or agents. If no name is listed, no name will be printed.						
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4a. The following fee(s) are submitted: ☐ Issue Fee ☐ Publication Fee (No small entity discount permitted) ☐ Advance Order - # of Copies				4b. Payment of Fee(s): (Please first reapply any previously paid issue fee shown above) ☐ A check is enclosed. ☐ Payment by credit card. Form PTO-2038 is attached. ☐ The Director is hereby authorized to charge the required fee(s), any deficiency, or credit any overpayment, to Deposit Account Number (enclose an extra copy of this form).						
5. Change in Entity Sta	itus (from status indicated as SMALL ENTITY statu	/	.27.	☐ b. Applicant is no lo	ong	er claiming SMAI	LL ENT	TITY status. See 37 CF	FR 1.27(g)(2).	
NOTE: The Issue Fee an interest as shown by the	d Publication Fee (if req records of the United Sta	uired) will not be tes Patent and Tr	accepte ademarl	ed from anyone other than						rty in
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SMITH PATENT	Γ OFFICE	LOGIE, MICHAEL J				
	ANIA AVENUE N W	ART UNIT PAPER NUMB				
SUITE 901 WASHINGTON, I	OC 20006	2881 DATE MAILED: 06/26/200	8			

Determination of Patent Term Adjustment under 35 U.S.C. 154 (b)

(application filed on or after May 29, 2000)

The Patent Term Adjustment to date is 291 day(s). If the issue fee is paid on the date that is three months after the mailing date of this notice and the patent issues on the Tuesday before the date that is 28 weeks (six and a half months) after the mailing date of this notice, the Patent Term Adjustment will be 291 day(s).

If a Continued Prosecution Application (CPA) was filed in the above-identified application, the filing date that determines Patent Term Adjustment is the filing date of the most recent CPA.

Applicant will be able to obtain more detailed information by accessing the Patent Application Information Retrieval (PAIR) WEB site (http://pair.uspto.gov).

Any questions regarding the Patent Term Extension or Adjustment determination should be directed to the Office of Patent Legal Administration at (571)-272-7702. Questions relating to issue and publication fee payments should be directed to the Customer Service Center of the Office of Patent Publication at 1-(888)-786-0101 or (571)-272-4200.

DETAILED ACTION

Response to Arguments

Applicant's arguments, see "Remarks" pages 9-10, filed 20 May 2008, with respect to claims 1-22 have been fully considered and are persuasive. The rejection of 01 February 2008 has been withdrawn.

Response to Amendment

An "Amendment" was received on 20 May 2008, in response to Office Action of 01 February 2008. Claims 11 and 22 have been cancelled. Claims 7, 10 and 18 have been amended. Claims 1-10 and 12-21 are pending.

Allowable Subject Matter

Claims 1-10 and 12-21 are allowed.

The scanning microscope configuration was not found in a prior art search. The search failed to show or suggest the prior use of:

• A mass spectrometer with an ionization unit, an extraction unit and an analysis unit, wherein the measurement probe has a hollow tip so that the near field of the measurement probe can be used by the ionization unit in such a way that ions are formed only in the near field of the measurement probe, and the shape of the measurement probe allows an essentially axially symmetrical field distribution of the extraction unit with respect to

the axis of the analysis unit in configuration with the limitations of claims 1 and 12.

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 Wherein the information from scanning probe microscopy and from mass spectrometry can be compared with high lateral resolution in configuration with the limitations of claims 7 and 18.

The following is an examiner's statement of reasons for allowance:

In regards to claim 1, prior art fails to disclose an apparatus for a scanning microscope, in particular a scanning force microscope, comprising a measurement probe which defines a near field, and having a scanning unit which allows the measurement probe to move relative to a sample in all three spatial directions, in conjunction with a mass spectrometer with an ionization unit, an extraction unit and an analysis unit, wherein the measurement probe has a hollow tip so that the near field of the measurement probe can be used by the ionization unit in such a way that ions are formed only in the near field of the measurement probe, and the shape of the measurement probe allows an essentially axially symmetrical field distribution of the extraction unit with respect to the axis of the analysis unit.

Claims 2-6 are allowed by virtue of their dependencies on the independent claim 1.

In regards to claim 7, prior art fails to disclose a method for high-resolution examination of a measurement sample using a combined scanning probe microscope, in particular a scanning force microscope, wherein the scanning probe microscope is first of all used to record an image of the measurement sample, in particular of the

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topography of the measurement sample, and wherein a mass spectrometer is then used for destructive, chemical characterization of at least subareas of sections of the measurement sample which are covered by the image, wherein the information from scanning probe microscopy and from mass spectrometry can be compared with high lateral resolution.

Claims 8-10 are allowed by virtue of their dependencies on the independent claim 7.

In regards to claim 12, prior art fails to disclose an apparatus for a scanning microscope, comprising a measurement probe which defines a near field and a scanning unit which allows the measurement probe to move relative to a sample in all three spatial directions in conjunction with a mass spectrometer with an ionization unit, an extraction unit and an analysis unit, wherein the measurement probe has a hollow tip so that the near field of the measurement probe can be used by the ionization unit such that ions are formed only in the near field of the measurement probe, and a shape of the measurement probe allows an essentially axially symmetrical field distribution of the extraction unit with respect to an axis of the analysis unit.

Claims 13-17 are allowed by virtue of their dependencies on the independent claim 12.

In regards to claim 18, prior art fails to disclose a method for high-resolution examination of a measurement sample using a combined scanning probe microscope, comprising the steps of: using the scanning probe microscope to record an image of the measurement sample; and using a mass spectrometer for destructive, chemical

characterization of at least subareas of sections of the measurement sample which are covered by the image; and further comprising a step of comparing information from the scanning probe microscope and from the mass spectrometer with high lateral resolution.

Claims 19-21 are allowed by virtue of their dependencies on the independent claim 18.

Conclusion

The prior art made of record and not relied upon is considered pertinent to applicant's disclosure. Pertinent prior art is closely related art that individually or in combination could be considered grounds for rejection. See references cited for a listing of the pertinent prior art found and the prior art found.

Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Michael J. Logie whose telephone number is 571-270-1616. The examiner can normally be reached on 7:30 to 5:00.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Robert Kim can be reached on 571-272-2293. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

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Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free). If you would like assistance from a USPTO Customer Service Representative or access to the automated information system, call 800-786-9199 (IN USA OR CANADA) or 571-272-1000.

/M. J. L./ Examiner, Art Unit 2881 /Jack I. Berman/ Primary Examiner, Art Unit 2881